

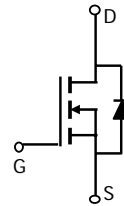
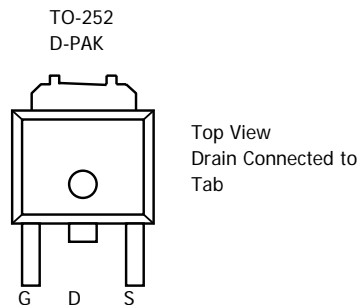
AOD454
N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOD454 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications. *Standard Product AOD454 is Pb-free (meets ROHS & Sony 259 specifications). AOD454L is a Green Product ordering option. AOD454 and AOD454L are electrically identical.*

Features

$V_{DS} (V) = 40V$
 $I_D = 12 A (V_{GS} = 10V)$
 $R_{DS(ON)} < 33 m\Omega (V_{GS} = 10V)$
 $R_{DS(ON)} < 47 m\Omega (V_{GS} = 4.5V)$


Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|-------------------|------------|
| Drain-Source Voltage | V_{DS} | 40 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^G | I_D | $T_C=25^\circ C$ | A |
| | | $T_C=100^\circ C$ | |
| Pulsed Drain Current ^C | I_{DM} | 30 | A |
| Avalanche Current ^C | I_{AR} | 12 | A |
| Repetitive avalanche energy $L=0.1mH$ ^C | E_{AR} | 20 | mJ |
| Power Dissipation ^B | P_D | $T_C=25^\circ C$ | W |
| | | $T_C=100^\circ C$ | |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ C$ | W |
| | | $T_A=70^\circ C$ | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 175 | $^\circ C$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|--------------|-----|--------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 17.4 | 30 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | | Steady-State | 50 | 60 |
| Maximum Junction-to-Case ^B | $R_{\theta JC}$ | 4 | 7.5 | $^\circ C/W$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|----------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =10mA, V _{GS} =0V | 40 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =32V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 1 | 2.3 | 3 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | 30 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =12A T _J =125°C | | 25 39 | 33 52 | mΩ |
| | | V _{GS} =4.5V, I _D =6A | | 34 | 47 | mΩ |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =12A | | 25 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.76 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 12 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =20V, f=1MHz | | 404 | 500 | pF |
| C _{oss} | Output Capacitance | | | 95 | 150 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 37 | 60 | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 2.7 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g (10V) | Total Gate Charge | V _{GS} =10V, V _{DS} =20V, I _D =12A | | 9.2 | | nC |
| Q _g (4.5V) | Total Gate Charge | | | 4.5 | | nC |
| Q _{gs} | Gate Source Charge | | | 1.6 | | nC |
| Q _{gd} | Gate Drain Charge | | | 2.6 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =20V, R _L =1.7Ω, R _{GEN} =3Ω | | 3.5 | | ns |
| t _r | Turn-On Rise Time | | | 6 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 13.2 | | ns |
| t _f | Turn-Off Fall Time | | | 3.5 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =12A, di/dt=100A/μs | | 22.9 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =12A, di/dt=100A/μs | | 18.3 | | nC |

A: The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The Power dissipation P_{D(SM)} is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175°C.

D: The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

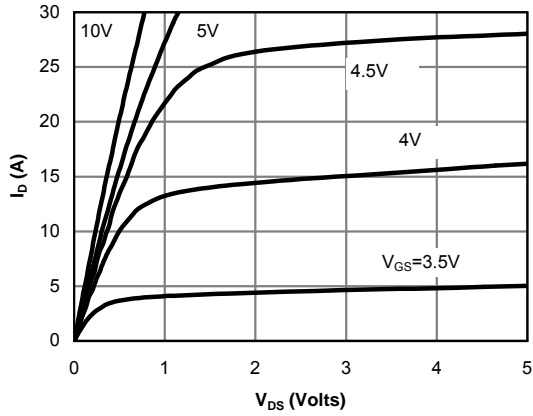


Fig 1: On-Region Characteristics

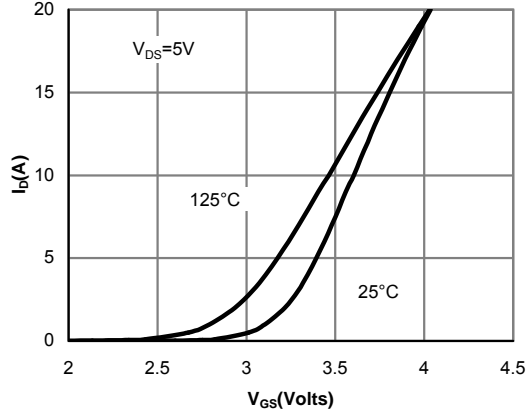


Figure 2: Transfer Characteristics

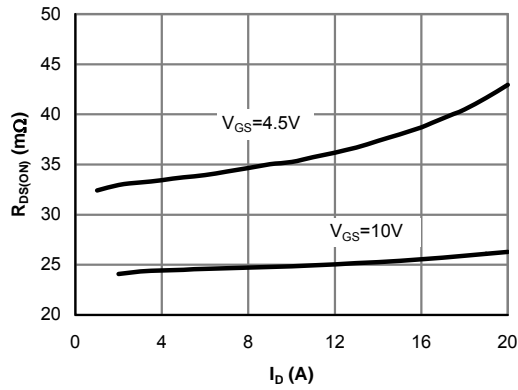


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

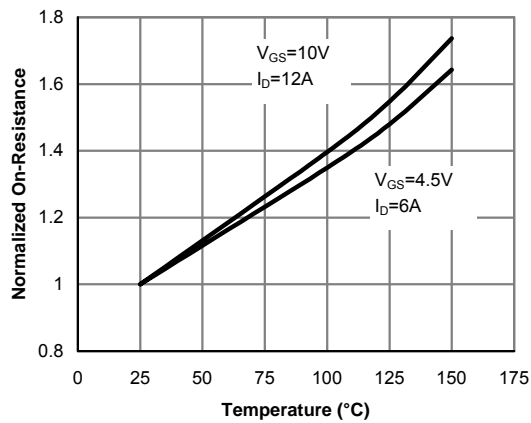


Figure 4: On-Resistance vs. Junction Temperature

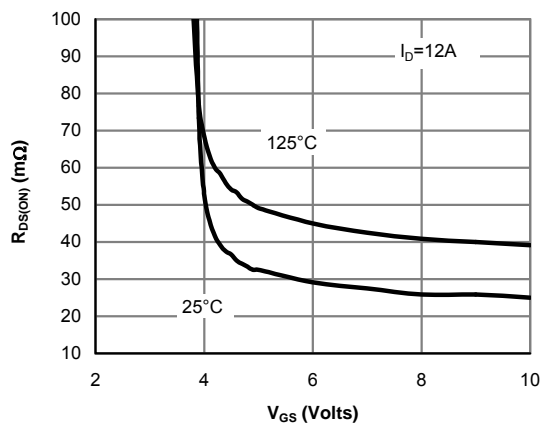


Figure 5: On-Resistance vs. Gate-Source Voltage

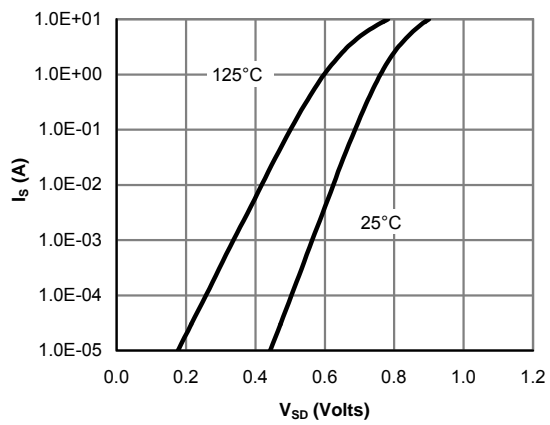


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

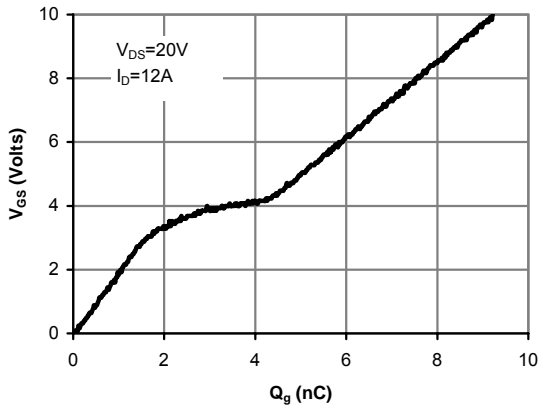


Figure 7: Gate-Charge Characteristics

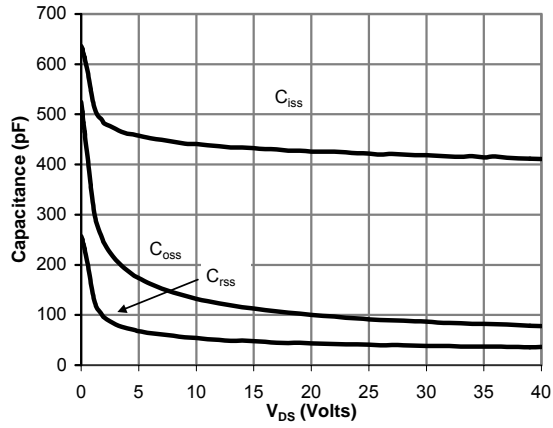


Figure 8: Capacitance Characteristics

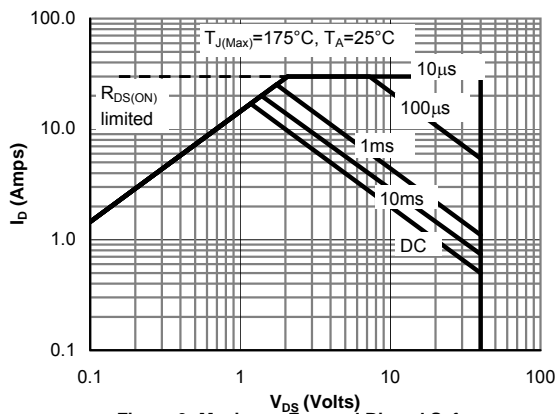


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

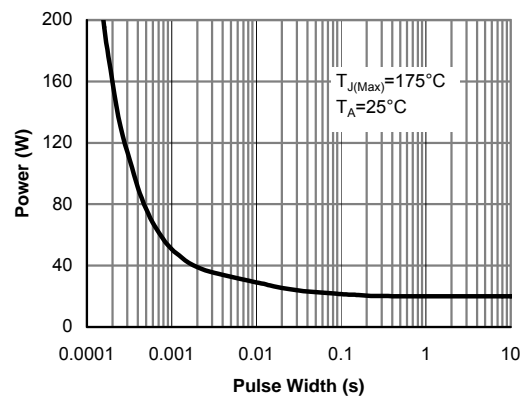


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

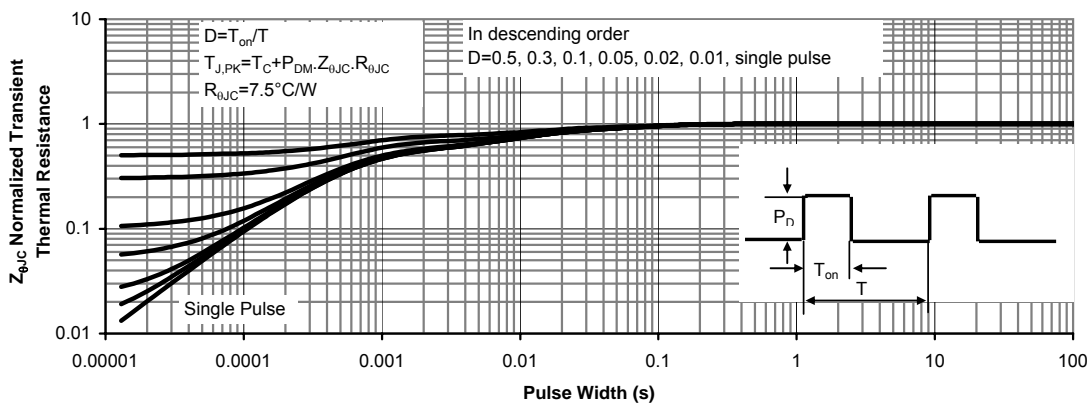


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

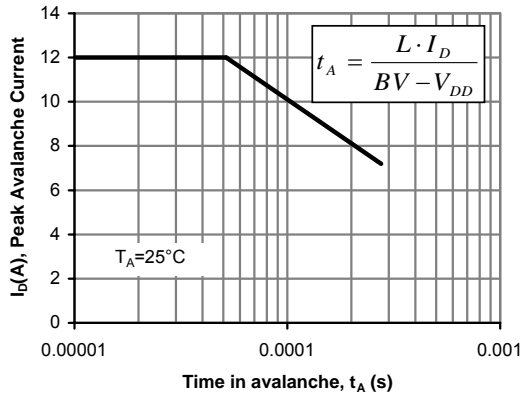


Figure 12: Single Pulse Avalanche capability

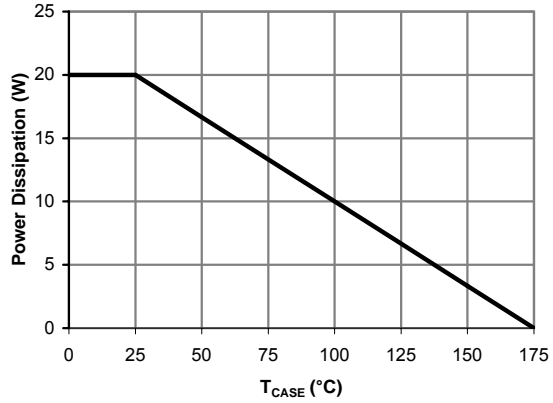


Figure 13: Power De-rating (Note B)

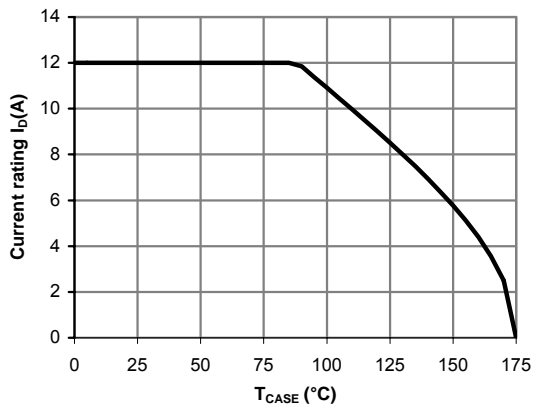


Figure 14: Current De-rating (Note B)

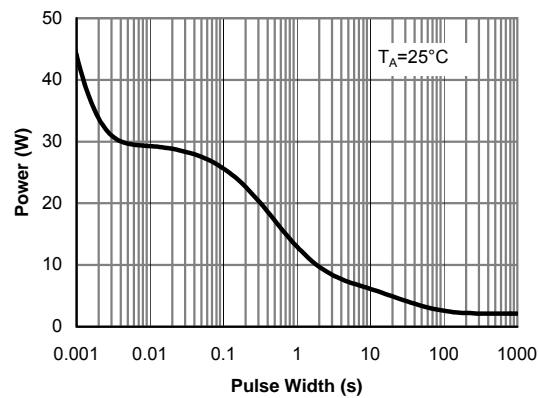


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

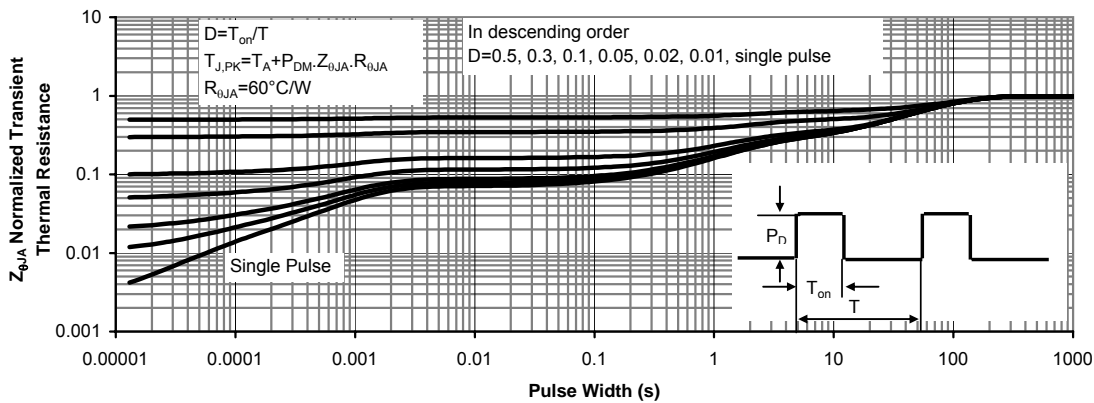


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)